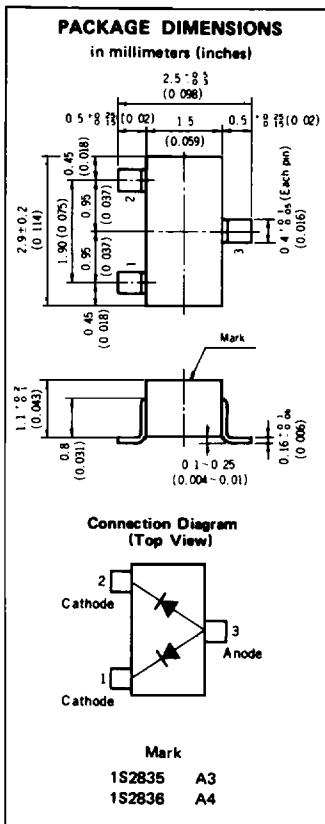


1S2835, 1S2836

High Speed Switching Silicon Epitaxial Double Diodes : Common Anode



- Low capacitance: $C_t = 2.5\text{pF}$ TYP.
- High speed switching: $t_{rr} = 4.0\text{ns}$ MAX.
- Wide applications including switching, limiter, clipper.
- Double diode configuration assures economical use.

ABSOLUTE MAXIMUM RATINGS

	IS2835	IS2836	
Peak Reverse Voltage	V_{RM}	35	75
DC Reverse Voltage	V_R	30	50
Surge Current ($1\ \mu\text{s}$)*	I_{FSM}	6.0	6.0
Surge Current ($1\ \mu\text{s}$)	I_{FSM}	4.0	4.0
Peak Forward Current*	I_{FM}	450	450
Peak Forward Current	I_{FM}	300	300
Average Rectified Current*	I_o	150	150
Average Rectified Current	I_o	100	100
Maximum Temperatures			
Junction Temperature	T_j	125	125
Storage Temperature Range	T_{stg}	-55 to +125	-55 to +125
Thermal Resistance			
Junction to Ambient*	$R_{th(j-a)}$	1.0	1.0
Junction to Ambient	$R_{th(j-a)}$	0.67	0.67

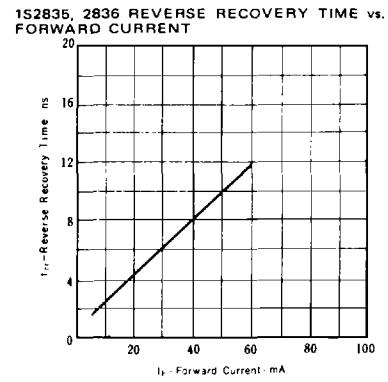
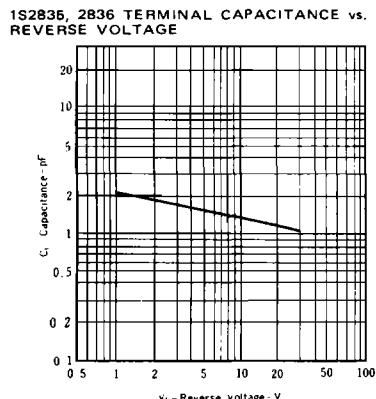
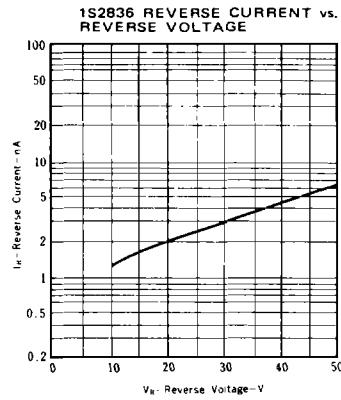
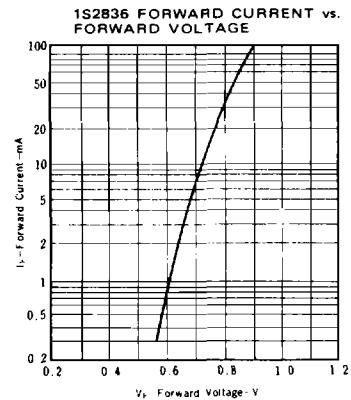
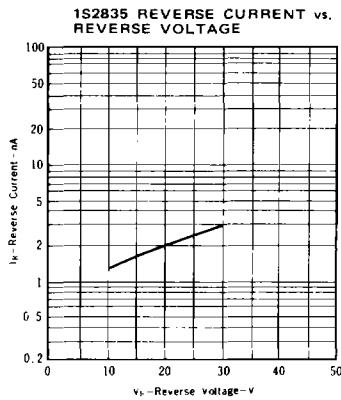
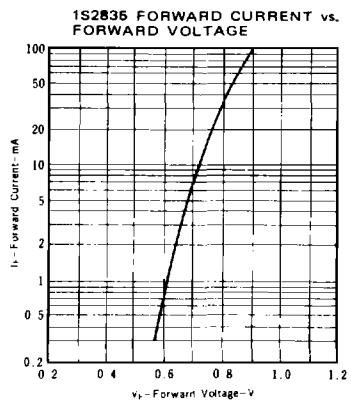
* Both diodes loaded simultaneously.

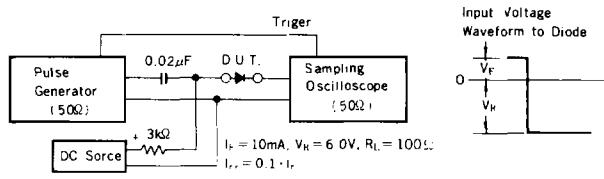
ELECTRICAL CHARACTERISTICS ($T_a = 25^\circ\text{C}$)

CHARACTERISTIC	SYMBOL	1S2835 (A3)			1S2836 (A4)			UNIT	TEST CONDITIONS
		MIN.	TYP.	MAX.	MIN.	TYP.	MAX.		
Forward Voltage	V_F1		0.72	1.0		0.72	1.0	V	$I_F=10\text{mA}$
	V_F2		0.83	1.0		0.83	1.0	V	$I_F=50\text{mA}$
	V_F3		0.9	1.2		0.9	1.2	V	$I_F=100\text{mA}$
Reverse Current	I_R			0.1				μA	$V_R=30\text{V}$
	I_R						0.1	μA	$V_R=50\text{V}$
Capacitance	C_t		2.5	4.0		2.5	4.0	pF	$V_R=0, f=1.0\text{MHz}$
Reverse Recovery Time	t_{rr}			4.0			4.0	ns	See test circuit.

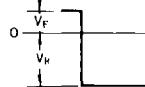
1S2835, 1S2836

TYPICAL CHARACTERISTICS ($T_a = 25^\circ C$)



t_{rr} REVERSE RECOVERY TIME TEST CIRCUIT

Input Voltage Waveform to Diode



Output Current Waveform in Diode

